

# PC905

## Long Creepage Distance Photocoupler with Built-in Voltage Detection Circuit

- \* Lead forming type (I type ) is also available. (PC905I)
- \*\* TÜV (DIN-VDE0884 ) approved type is also available as an option.

### ■ Features

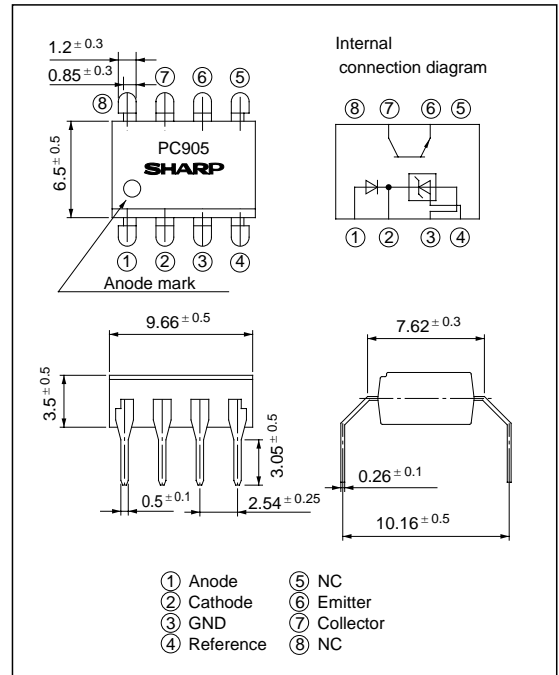
1. Built-in voltage deviation detection circuit
2. Long creepage distance type  
(Creepage distance : 8mm or more)
3. Conforms to European Safety Standard  
(Internal insulation distance : 0.5mm or more)
4. High collector-emitter voltage ( $V_{CEO}$  : 70V)
5. High isolation voltage between input and output ( $V_{iso}$  : 5 000V<sub>rms</sub>)
6. Recognized by UL, file No. E64380  
Approved by BSI (BS415 : No. 6990, BS7002 : No. 7567)  
Approved by SEMKO No. 963501101  
Approved by DEMKO No. 392592

### ■ Applications

1. Switching power supplies

### ■ Outline Dimensions

( Unit : mm )



### ■ Absolute Maximum Ratings

( $T_a = 25^\circ\text{C}$ )

	Parameter	Symbol	Rating	Unit
Input	Anode current	$I_A$	50	mA
	Anode voltage	$V_A$	30	V
	Reference input current	$I_{REF}$	10	mA
	Power dissipation	$P$	250	mW
Output	Collector-emitter voltage	$V_{CEO}$	70	V
	Emitter-collector voltage	$V_{ECO}$	6	V
	Collector current	$I_C$	50	mA
	Collector power dissipation	$P_C$	150	mW
	Total power dissipation	$P_{tot}$	350	mW
	*1 Isolation voltage	$V_{iso}$	5 000	V <sub>rms</sub>
	Operating temperature	$T_{opr}$	- 25 to + 85	$^\circ\text{C}$
	Storage temperature	$T_{stg}$	- 40 to + 125	$^\circ\text{C}$
	*2 Soldering temperature	$T_{sol}$	260	$^\circ\text{C}$

\*1 40 to 60% RH, AC for 1 minute

\*2 For 10 seconds

## Electro-optical Characteristics

( $T_a = 25^\circ\text{C}$  unless otherwise specified.)

	Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	Fig.
Input	Reference voltage	$V_{REF}$	$V_K = V_{REF}, I_A = 10\text{mA}$	2.40	2.495	2.60	V	1
	*3 Temperature change in reference voltage	$V_{REF}(\text{dev})$	$V_K = V_{REF}, I_A = 10\text{mA}, T_a = -25 \text{ to } +85^\circ\text{C}$	-	8	40	mV	1
	Voltage variation ratio in reference voltage	$\Delta V_{REF} / \Delta V_A$	$I_A = 10\text{mA}, \Delta V_A = 30\text{V} - V_{REF}$	-	-1.4	-5	mV/V	2
	Reference input current	$I_{REF}$	$I_A = 10\text{mA}, R_3 = 10\text{k}\Omega$	-	2	10	$\mu\text{A}$	3
	*4 Temperature change in reference input current	$I_{REF}(\text{dev})$	$I_A = 10\text{mA}, R_3 = 10\text{k}\Omega, T_a = -25 \text{ to } +85^\circ\text{C}$	-	0.4	3	$\mu\text{A}$	3
	Minimum drive current	$I_{MIN}$	$V_K = V_{REF}$	-	1	2	mA	1
	OFF-state anode current	$I_{OFF}$	$V_A = 30\text{V}, V_{REF} = \text{GND}$	-	0.1	2	$\mu\text{A}$	4
	Anode-cathode forward voltage	$V_F$	$V_K = V_{REF}, I_A = 10\text{mA}$	-	1.2	1.4	V	1
Output	Collector dark current	$I_{CEO}$	$V_{CE} = 20\text{V}$	-	$10^{-9}$	$10^{-7}$	A	5
Transfer characteristics	*5 Current transfer ratio	CTR	$V_K = V_{REF}, I_A = 10\text{mA}, V_{CE} = 5\text{V}$	40	-	320	%	6
	Collector-emitter saturation voltage	$V_{CE}(\text{sat})$	$V_K = V_{REF}, I_A = 20\text{mA}, I_C = 1\text{mA}$	-	0.1	0.2	V	6
	Isolation resistance	$R_{ISO}$	40 to 60% RH, DC500V	$5 \times 10^{10}$	$1 \times 10^{11}$	-	$\Omega$	-
	Floating capacitance	$C_f$	$V = 0, f = 1\text{MHz}$	-	0.6	1.0	pF	-

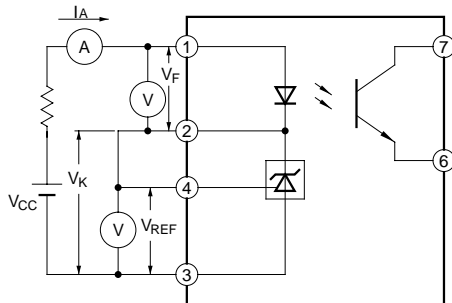
\*3  $V_{REF}(\text{dev}) = V_{REF}(\text{MAX.}) - V_{REF}(\text{MIN.})$

\*4  $I_{REF}(\text{dev}) = I_{REF}(\text{MAX.}) - I_{REF}(\text{MIN.})$

\*5  $\text{CTR} = I_C / I_A \times 100(\%)$

## Test Circuit

Fig. 1



$V_K$  : Voltage between terminals ② and ③

$V_{REF}$  : Voltage between terminals ③ and ④

Fig. 2

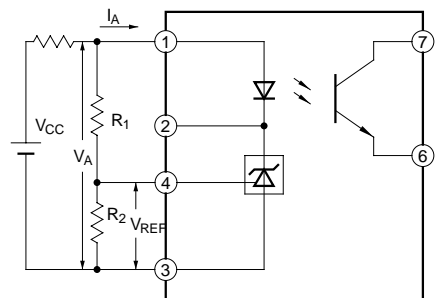


Fig. 3

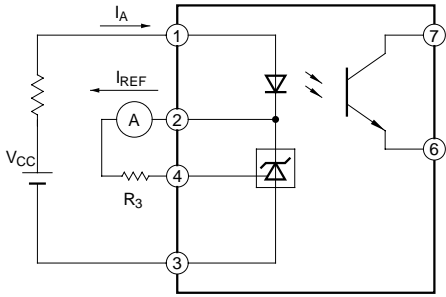


Fig. 4

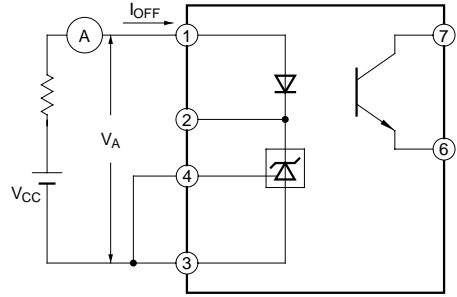


Fig. 5

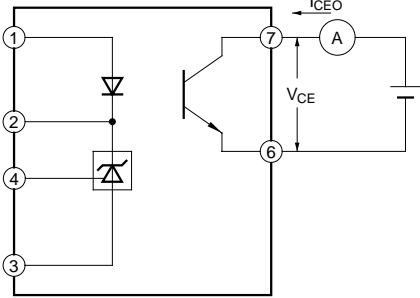


Fig. 6

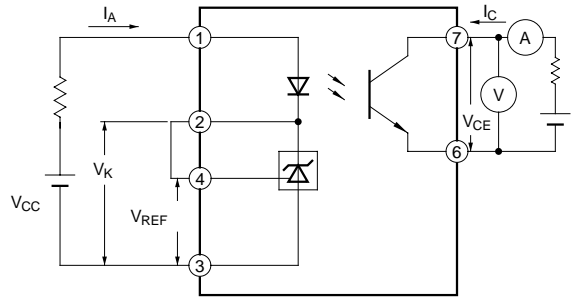


Fig. 7 Anode Current vs. Ambient Temperature

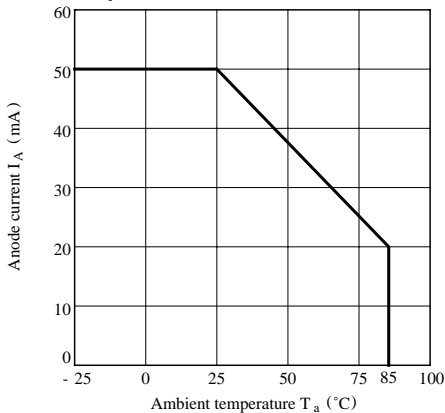
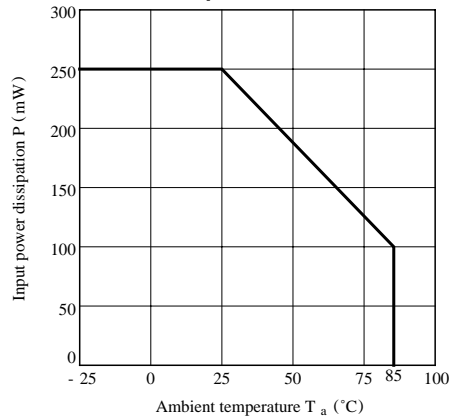
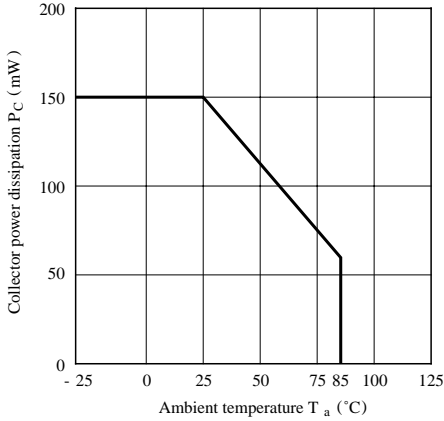


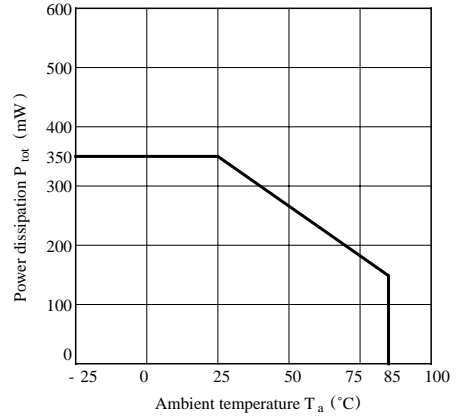
Fig. 8 Input Power Dissipation vs. Ambient Temperature



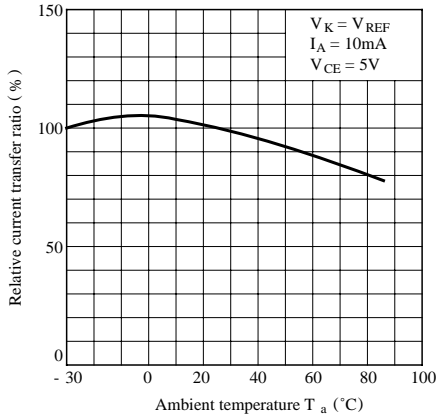
**Fig. 9 Collector Power Dissipation vs. Ambient Temperature**



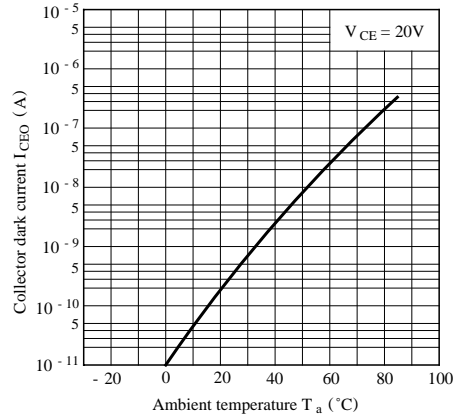
**Fig.10 Power Dissipation vs. Ambient Temperature**



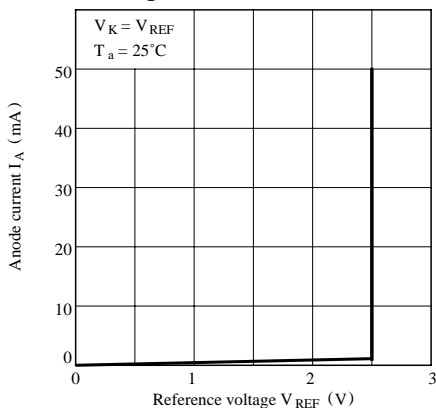
**Fig.11 Relative Current Transfer Ratio vs. Ambient Temperature**



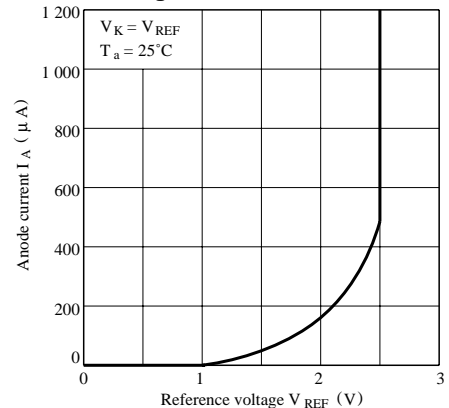
**Fig.12 Collector Dark Current vs. Ambient Temperature**



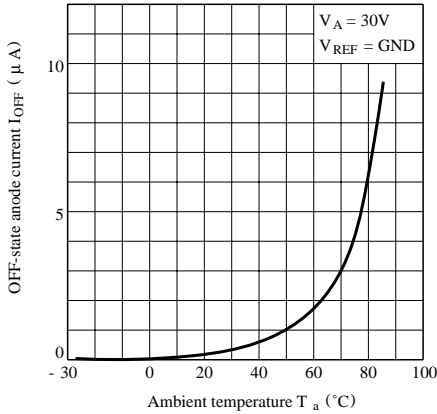
**Fig.13-a Anode Current vs. Reference Voltage**



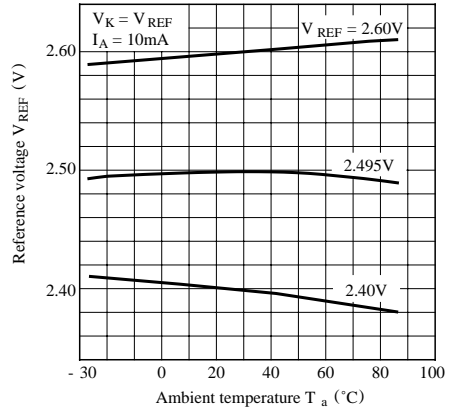
**Fig.13-b Anode Current vs. Reference Voltage**



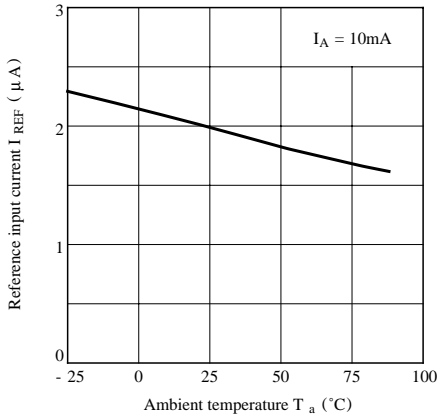
**Fig.14 OFF-state Anode Current vs. Ambient Temperature**



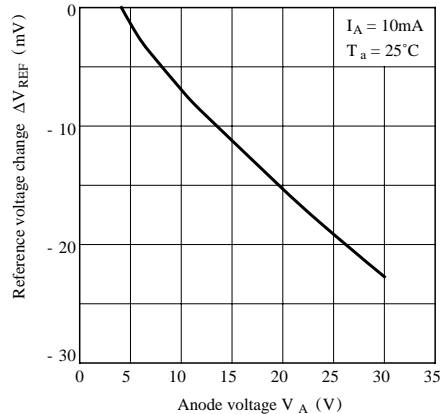
**Fig.15 Reference Voltage vs. Ambient Temperature**



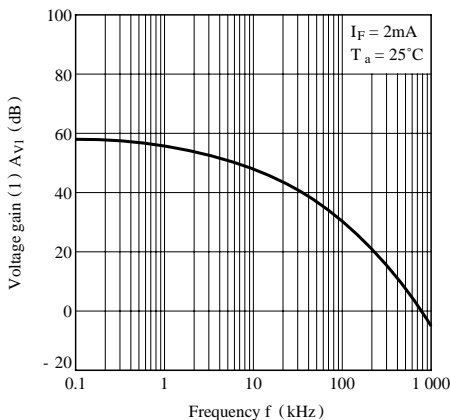
**Fig.16 Reference Input Current vs. Ambient Temperature**



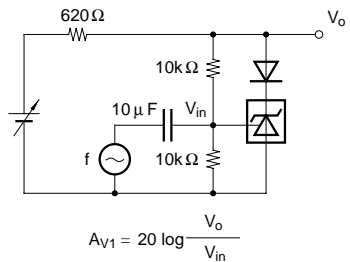
**Fig.17 Reference Voltage Change vs. Anode Voltage**



**Fig.18-a Voltage Gain (1) vs. Frequency**

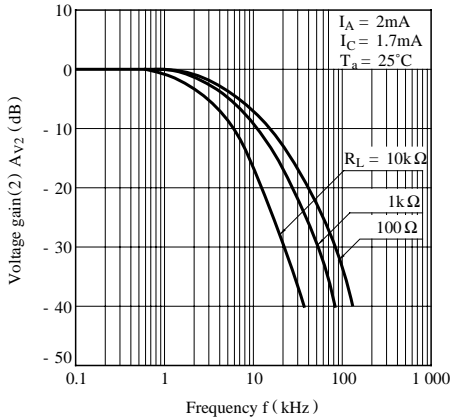


**Test Circuit for Voltage Gain (1) vs. Frequency**



$$A_{V1} = 20 \log \frac{V_o}{V_{in}}$$

Fig.18-b Voltage Gain (2) vs. Frequency



Test Circuit for Voltage Gain (2) vs. Frequency

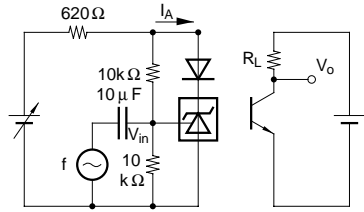
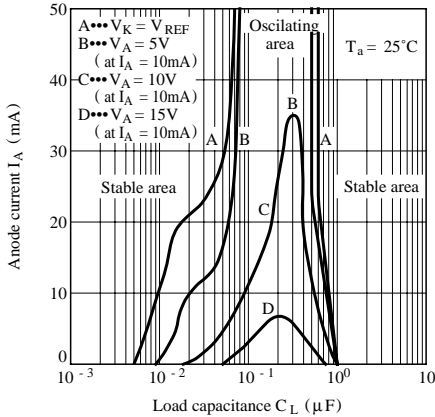


Fig.19 Anode Current vs. Load Capacitance



Test Circuit for Anode Current vs. Load Capacitance

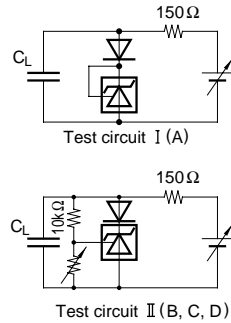


Fig.20 Collector-emitter Saturation Voltage vs. Ambient Temperature

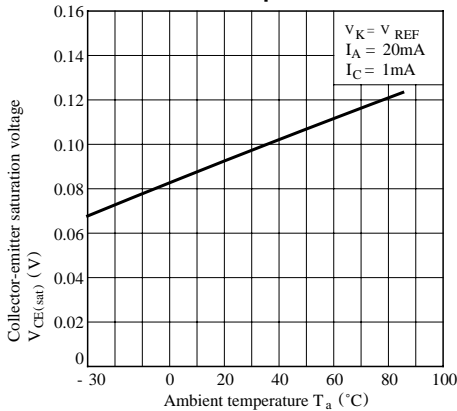
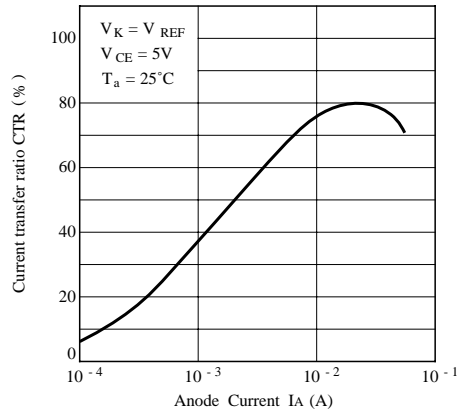


Fig.21 Current Transfer Ratio vs. Anode Current



■ Precautions for Use

Handle this product the same as with other integrated circuits against static electricity.

- As for other general cautions, refer to the chapter "Precautions for Use"